



• Extinction and absorption



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- Perfect crystal integrated intensity



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- Comparison of intensities



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- Comparison of intensities
- Absorption, energy, and order effects



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Reading Assignment: Chapter 6.5; Chapter 7.1



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Reading Assignment: Chapter 6.5; Chapter 7.1

Homework Assignment #05: Chapter 5: 1,3,7,9,10 due Tuesday, November 02, 2021



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- Perfect crystal integrated intensity
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Reading Assignment: Chapter 6.5; Chapter 7.1

Homework Assignment #05: Chapter 5: 1,3,7,9,10 due Tuesday, November 02, 2021 Homework Assignment #06: Chapter 6: 1,6,7,8,9 due Tuesday, November 16, 2021



Starting with a single layer, the Darwin theory of diffraction from a perfect crystal is developed giving the reflectivity R(x) where $\epsilon = \Delta - g_0$, $i\eta = \pm \sqrt{\epsilon^2 - g^2}$, and $x = \epsilon/g$



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the Darwin curve has 100% reflectivity across a width that varies inversely with the order, *m*, of the reflection

Carlo Segre (Illinois Tech)



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the relative phase between the scattered and transmitted waves varies from out of phase at x = -1 to in phase at x = +1

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$$f_{xt}(x=0) = \frac{1}{2g} = \frac{1}{4} \left(\frac{d}{d}\right) \frac{1}{r_0}$$

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$$\Lambda_{ext}(x=0) = \frac{d}{2g} = \frac{1}{4} \left(\frac{m}{d}\right) \frac{v_c}{r_0 |F|}$$

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The extinction depth depends on the structure factor and thus will vary significantly depending on the strength of the particular Bragg reflection

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For the strong (400) reflection of GaAs



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so that $\Lambda_{ext}(200) = 8.1 \,\mu\text{m}$ and $\sin \theta / 2\mu = 3.9 \,\mu\text{m}$, which is 2 times smaller

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Starting with the expression for the Darwin curve it is possible to integrate and compute the integrated intensity of the reflected x-rays

converting into an integrated intensity in terms of the variable ζ

$$I_{\zeta} = \frac{8}{3} \frac{g}{m\pi}$$

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$$I_{\zeta} = \frac{8}{3} \frac{g}{m\pi} = \frac{8}{3} \frac{1}{m\pi} \frac{2d^2|F|}{v_c \sin^2 \theta}$$

$$R(x) = \begin{cases} (x - \sqrt{x^2 - 1})^2 & x \ge 1\\ 1 & |x| \le 1\\ (x + \sqrt{x^2 - 1})^2 & x \le -1 \end{cases}$$
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Starting with the expression for the Darwin curve it is possible to integrate and compute the integrated intensity of the reflected x-rays

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$$I_{SC}^{P} = \Phi_0 A_0 \frac{8\lambda^2 r_0 |F|}{6\pi v_c \sin^2 \theta} \tan \theta \left(\frac{1 + |\cos 2\theta|}{2}\right) e^{-M}$$

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Comparing the integrated intensity from a perfect crystal with that which was calculated for a mosaic crystal

Perfect crystal

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Taking the ratio of these two intensities shows that the intensity from a mosiac crystal is significantly different than from a perfect crystal

$$\frac{I_{SC}^{M}}{I_{SC}^{P}} = \left(\frac{3\pi}{16}\right) \frac{\lambda r_{0}|F|}{\mu v_{c}} \left(\frac{1+\cos^{2}2\theta}{1+|\cos 2\theta|}\right) e^{-M}$$

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Comparing the integrated intensity from a perfect crystal with that which was calculated for a mosaic crystal

Perfect crystal

$$I_{SC}^{P} = \frac{8\Phi_{0}A_{0}\lambda^{2}r_{0}|F|}{3\pi\nu_{c}\sin 2\theta} \left(\frac{1+|\cos 2\theta|}{2}\right)e^{-M} \qquad I_{SC}^{M} = \frac{\Phi_{0}A_{0}\lambda^{3}r_{0}^{2}|F|^{2}}{2\mu\nu_{c}^{2}\sin 2\theta} \left(\frac{1+\cos^{2}2\theta}{2}\right)e^{-2M}$$

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For the strong (400) reflection of GaAs this approximate ratio is $I_{SC}^M/I_{SC}^P \approx 6$ while for the weak (200) reflection it is $I_{SC}^M/I_{SC}^P \approx 0.2$

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The displacement of the Darwin curve varies inversely as the order, m, of the reflection.



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By tuning to the center of a lower order reflection, the high orders can be effectively suppressed.



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By tuning to the center of a lower order reflection, the high orders can be effectively suppressed.

By tuning a bit off on the "high" side we get even more suppression. This is called "detuning".

We can calculate the angular offset by noting that the offset and width have many common factors.







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For the Si(111) at $\lambda = 1.54056$ Å :

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For the Si(111) at $\lambda = 1.54056$ Å :

$$\omega_D^{total}=0.0020^\circ$$
 ,

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Darwin widths



	$\zeta_{\rm d}^{\rm fwhm} imes 10^6$								
	(111)			(220)			(400)		
Diamond	61.0			20.9			8.5		
<i>a</i> = 3.5670 Å	3.03	0.018	-0.01	1.96	0.018	-0.01	1.59	0.018	-0.01
Silicon	139.8			61.1			26.3		
<i>a</i> = 5.4309 Å	10.54	0.25	-0.33	8.72	0.25	-0.33	7.51	0.25	-0.33
Germanium	347.2			160.0			68.8		
<i>a</i> = 5.6578 Å	27.36	-1.1	-0.89	23.79	-1.1	-0.89	20.46	-1.1	-0.89

the quantities below the widths are $f^0(Q)$, f', and f'' (for $\lambda = 1.5405$ Å). For an angular width, multiply times tan θ and for π polarization, multiply by $\cos(2\theta)$.

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Absorption effects



The transmitted and scattered waves in a perfect crystal have both a phase shift and an attenuation due to absorption


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The transmitted and scattered waves in a perfect crystal have both a phase shift and an attenuation due to absorption

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The transmitted and scattered waves in a perfect crystal have both a phase shift and an attenuation due to absorption

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$$F_0 = \sum_j (Z_j + f'_j + if''_j)$$



The transmitted and scattered waves in a perfect crystal have both a phase shift and an attenuation due to absorption

$$g_{0} = \left(\frac{2d^{2}r_{0}}{mv_{c}}\right)F_{0} \qquad g = \left(\frac{2d^{2}r_{0}}{mv_{c}}\right)F$$

$$F_{0} = \sum_{j}(Z_{j} + f_{j}' + if_{j}'') \qquad F_{0} = \sum_{j}(f_{j}^{0}(\vec{Q})_{j} + f_{j}' + if_{j}'')e^{i\vec{Q}\cdot\vec{r}_{j}}$$

V

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the phase shift is proportional to g_0 which is real, however, by adding an imaginary component, absorption can be included in the model

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the variable x that parametrizes the reflectivity now is complex

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$$(x_c) = \begin{cases} \frac{1}{x_c + \sqrt{x_c^2 - 1}} \approx x_c - \sqrt{x_c^2 - 1} & Re\{x_c\} \ge +1\\ \frac{1}{x_c + i\sqrt{x_c^2 - 1}} \approx x_c - i\sqrt{x_c^2 - 1} & |Re\{x_c\}| \le 1\\ \frac{1}{x_c - \sqrt{x_c^2 - 1}} \approx x_c + \sqrt{x_c^2 - 1} & Re\{x_c\} \le -1 \end{cases}$$

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Silicon (111) Darwin curves





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solid line is for $\lambda = 0.70926$ Å





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note that width of Darwin curve is independent of wavelength

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The angular Darwin width, w_D does depend on energy

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The angular Darwin width, w_D does depend on energy

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The angular Darwin width, w_D does depend on energy and polarization of the beam

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When the Bragg condition is met for a perfect crystal, the total wavefield above the crystal is made up of the incident and diffracted wavefields, $T \propto e^{ik_y y} e^{ik_z z}$ and $S \propto e^{ik_y y} e^{-ik_z z}$



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as x varies along the Darwin curve, the phase of the standing wave at a position z varies by π

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This can be done most effectively by tuning the energy through the Darwin width of the rocking curve

A high resolution monochromator is required for this kind of experiment

Beam line ID32 @ ESRF





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Structure of Sn on Ge(111)

The low temperature 3×3 structure (dashed line) is well known but the room temperature $\sqrt{3}\times\sqrt{3}$ surface structure (solid line) is unresolved





"Chemically resolved structure of the Sn/Ge(111) surface," T.-L. Lee, S. Warren, B.C.C. Cowie, and J. Zengenhagen, Phys. Rev. Lett. 96, 046103 (2006).

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Structure of Sn on Ge(111)

The low temperature 3×3 structure (dashed line) is well known but the room temperature $\sqrt{3}\times\sqrt{3}$ surface structure (solid line) is unresolved

A sub-monolayer of Sn is evaporated on a clean Ge(111) surface and studied using x-ray standing wave stimulated photoelectron spectroscopy



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Above 0.2 ML, the $\sqrt{3}\times\sqrt{3}$ structure appears and then dominates









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With an incident energy of 2.5 keV, the 2 \times 2 and $\sqrt{3} \times \sqrt{3}$ structures are measured in an off-Bragg condition

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The lines for both the Sn $3d_{5/2}$ and 4d peaks in the 2×2 phase are sharp, indicating a single chemical state

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4d

 $3^{1/2} \times 3^{1/2}$

2x2

 $3d_{5/2}$

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The $\sqrt{3} \times \sqrt{3}$ structure shows two distinct chemical shifts, with the majority component, l_1 , having a slightly lower binding energy than the minority component, l_2

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Relative Binding Energy (eV)

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By varying the energy with a resolution of 500 meV, the standing wave is swept through the Sn layer $% \left({{{\rm{S}}_{\rm{s}}}} \right)$

Sn 4d ΔE Sn 3d 1.35 e\/ 1.05 Normalized Intensity (arb. units) 0.75 0.45 0.14 -0.13 -1 -1 Relative Binding Energy (eV)

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At $\Delta E_{\gamma} = 0.45$ eV, the I_1/I_2 ratio almost completely inverts, showing that the two atom populations are at different heights above the surface

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The normalized peak intensities can be fitted to extract the relative positions of the two populations of atoms and their atomic ratio

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Population 1 is two times larger than population 2and is located a height $\Delta h = 0.23$ Å further from the Ge(111) surface

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The normalized peak intensities can be fitted to extract the relative positions of the two populations of atoms and their atomic ratio

Population 1 is two times larger than population 2 and is located a height $\Delta h = 0.23$ Å further from the Ge(111) surface

Population 1 also has a lower binding energy, demonstrating that the binding energy is directly correlated to the height from the surface

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output divergence on left, input divergence on right

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